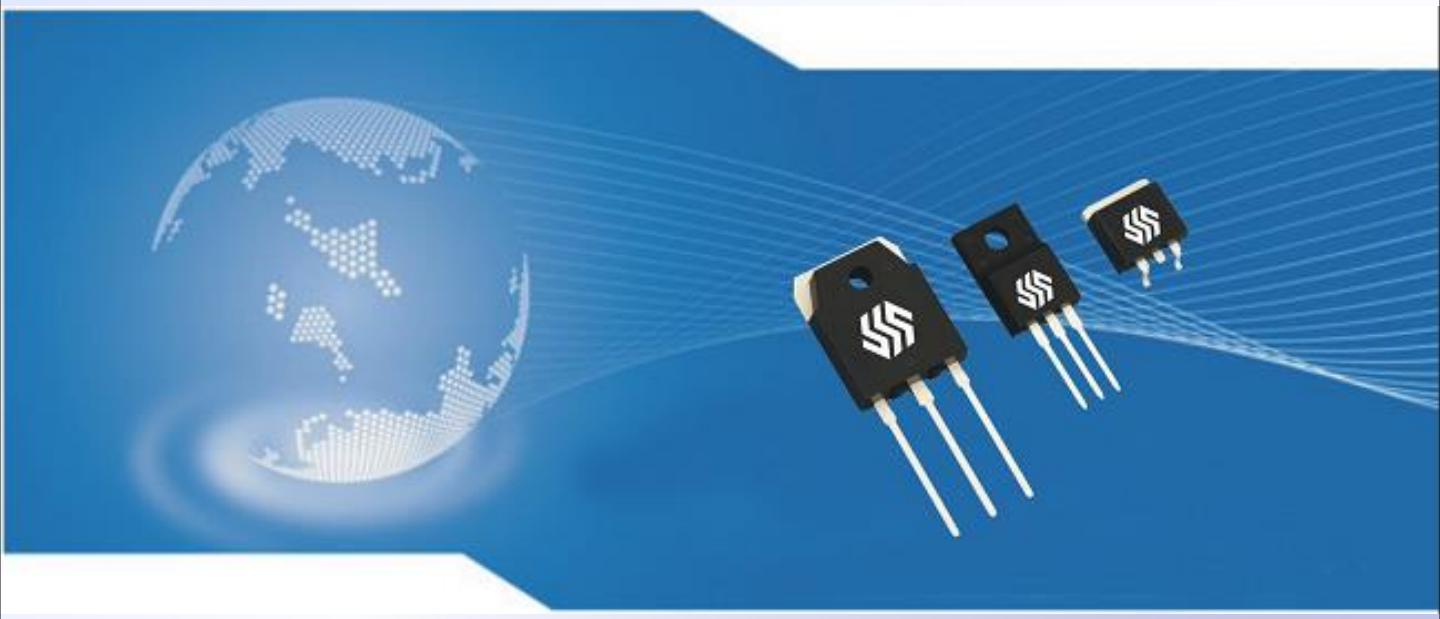
SUPER-SEMI



SUPER-MOSFET

Super Junction Metal Oxide Semiconductor Field Effect Transistor

800V Super Junction Power MOSFET
SS*80R500S

Rev. 1.6
Aug. 2019

www.supersemi.com.cn

SSF80R500S/SSP80R500S/SSB80R500S/SST80R500S
800V N-Channel MOSFET

Description

SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.
This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy.
SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

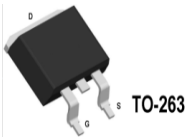
Features

- Multi-Epi process SJ-FET
- 850V @TJ = 150 ℃
- Typ. RDS(on) = 0.48Ω
- Ultra Low Gate Charge (typ. Qg = 13nC)
- 100% avalanche tested

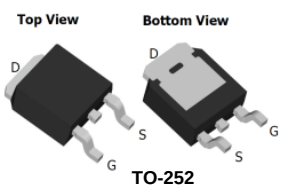
SSF80R500S

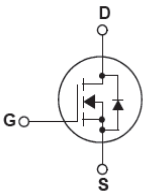
SSP80R500S

SSB80R500S



SST80R500S





Absolute Maximum Ratings

Symbol	Parameter	SSP_B_T80R500S	SSF80R500S	Unit
V_{DSS}	Drain-Source Voltage	800		V
I_D	Drain Current -Continuous (TC = 25℃) -Continuous (TC = 100℃)	10.5* 6.7*		A
I_{DM}	Drain Current - Pulsed (Note 1)	30*		A
V_{GSS}	Gate-Source voltage	±30		V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	210		mJ
I_{AR}	Avalanche Current (Note 1)	1.8		A
E_{AR}	Repetitive Avalanche Energy (Note 1)	0.32		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15		V/ns
dVds/dt	Drain Source voltage slope (Vds=640V)	50		V/ns
P_D	Power Dissipation (TC = 25℃)	83	31	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150		℃
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300		℃

* Drain current limited by maximum junction temperature. Maximum duty cycle D=0.75.

Thermal Characteristics

Symbol	Parameter	SSP_B_T80R500S	SSF80R500S	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.5	4.0	℃/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	-	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	80	℃/W

Electrical Characteristics TC = 25℃ unless otherwise noted

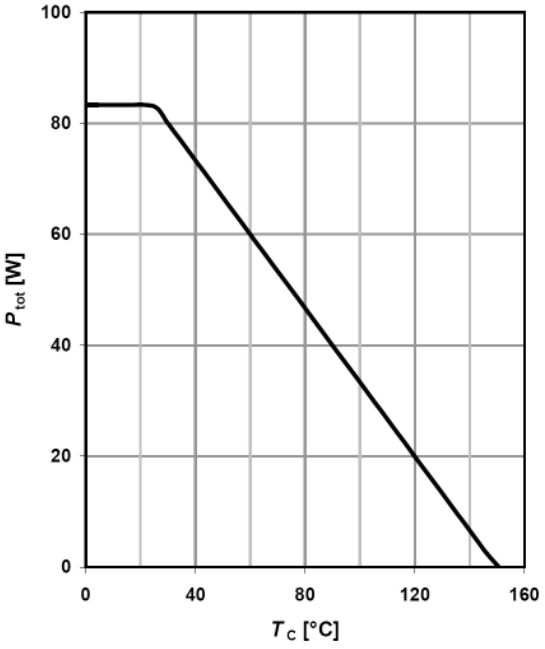
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V, I_D = 250μA, T_J = 25℃	800	-	-	V
		V_{GS} = 0V, I_D = 250μA, T_J = 150℃	-	850	-	V
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	I_D = 250μA, Referenced to 25℃	-	0.6	-	V/℃
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 800V, V_{GS} = 0V -T_J = 150℃	-	- 10	1 -	μA μA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30V, V_{DS} = 0V	-	-	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30V, V_{DS} = 0V	-	-	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250μA	2.5	3.5	4.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10V, I_D = 5.5A (TO-220F/TO-220/TO-263)	-	0.48	0.52	Ω
		V_{GS} = 10V, I_D = 5.5A (TO-252)	-	0.51	0.55	Ω
g_{FS}	Forward Transconductance	V_{DS} = 40V, I_D = 11A	-	9	-	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25V, V_{GS} = 0V, f = 1MHz	-	630	-	pF
C_{oss}	Output Capacitance		-	180	-	pF
C_{rss}	Reverse Transfer Capacitance		-	11	-	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 400V, I_D = 5.5A, R_G = 25Ω(Note 4)	-	28	-	ns
t_r	Turn-On Rise Time		-	19	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	65	-	ns
t_f	Turn-Off Fall Time		-	19	-	ns
Q_g	Total Gate Charge	V_{DS} = 450V, I_D = 5.5A, V_{GS} = 10V (Note 4)	-	13	-	nC
Q_{gs}	Gate-Source Charge		-	3.4	-	nC
Q_{gd}	Gate-Drain Charge		-	4.9	-	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		-	-	11	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	30	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0V, I_S = 11A	-	0.9	1.5	V
t_{rr}	Reverse Recovery Time	V_R = 400V,V_{GS} = 0V, I_F = 11A, dI$_F$/dt =100A/μs	-	600	-	ns
Q_{rr}	Reverse Recovery Charge		-	7.2	-	μC
I_{rrm}	Peak reverse recovery Current		-	22	-	A

NOTES:

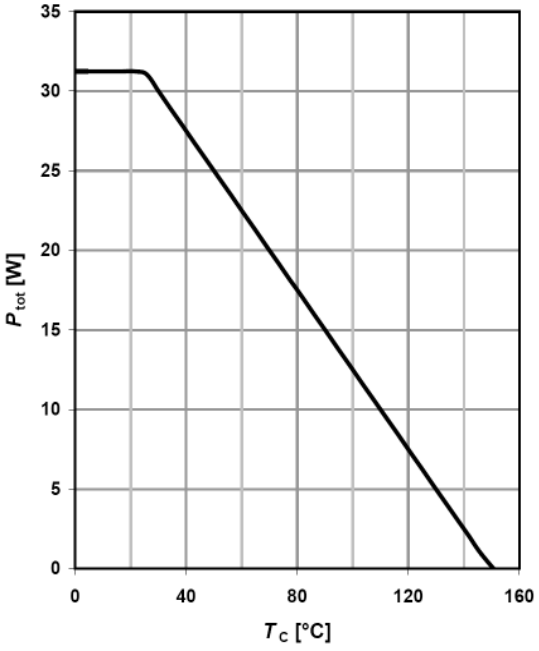
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. I_{AS}=1.8A, VDD=50V, Starting TJ=25 ℃
3. I_{SD}≤ID, di/dt ≤ 200A/us, V_{DD} ≤ BV_{DSS}, Starting TJ = 25 ℃
4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

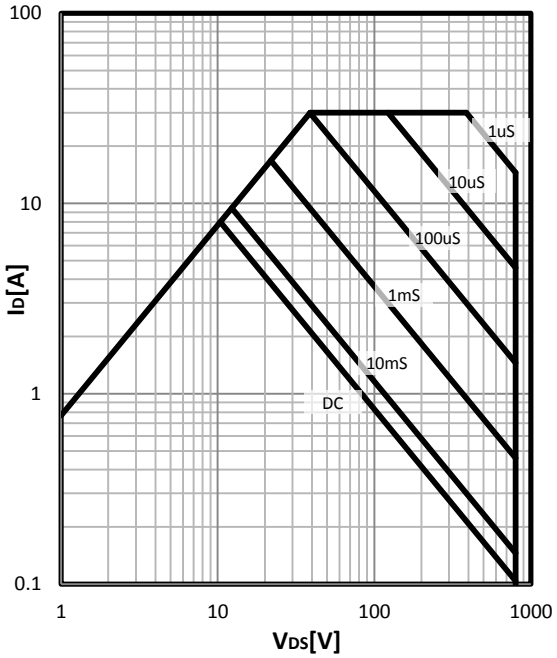
Power dissipation
$P_{tot}=f(T_C)$; TO-220,TO-252,TO-263



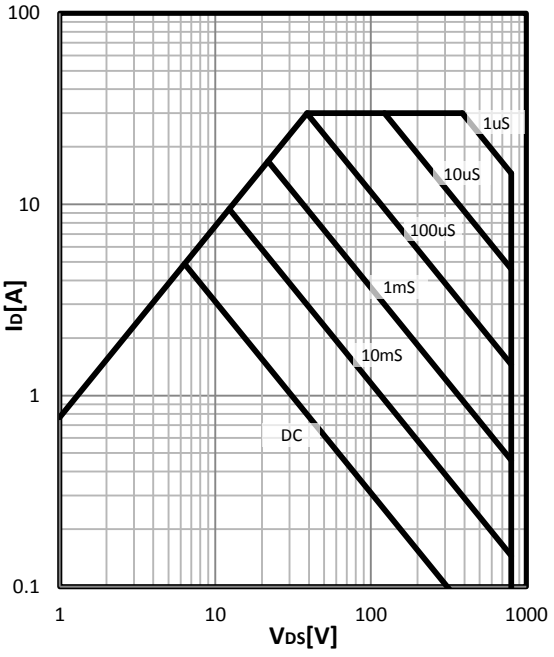
Power dissipation
$P_{tot}=f(T_C)$; TO-220FullPAK



Safe Operating area Tc=25℃
$I_D=f(V_{DS})$; D=0; parameter t_p ; TO-220,TO-252,TO-263



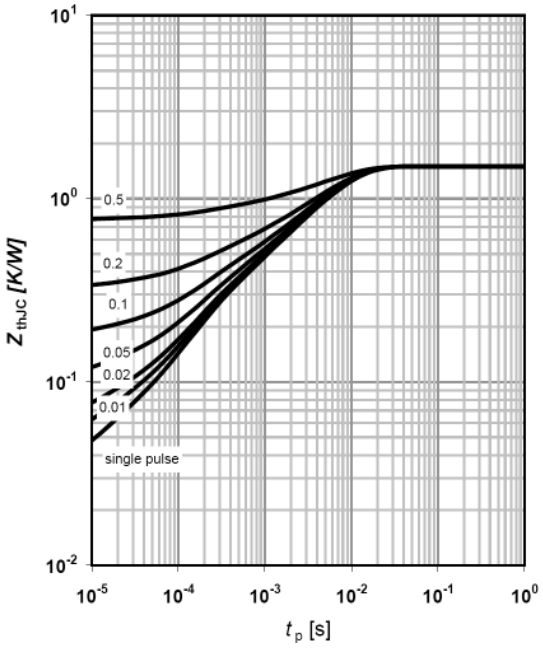
Safe Operating area Tc=25℃
$I_D=f(V_{DS})$; D=0; parameter $t_{p,}$; TO-220FullPAK



Typical Performance Characteristics

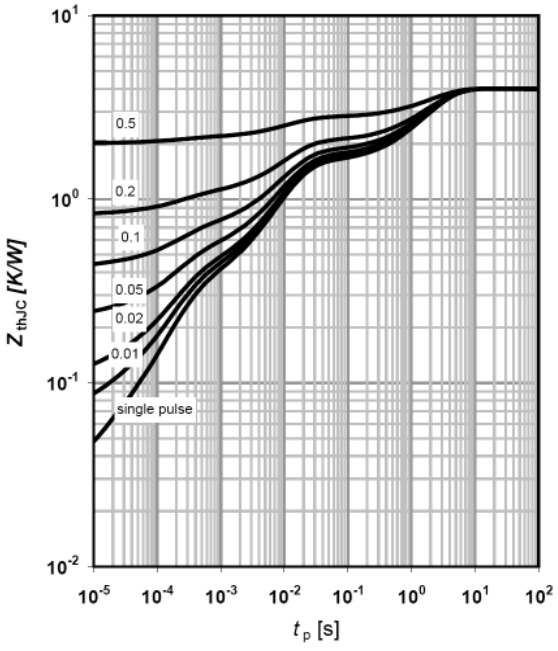
Max. Transient thermal impedance

$Z_{(thJC)}$=f(tp);Parameter: D=t_p/T; TO-220,TO-252,TO-263



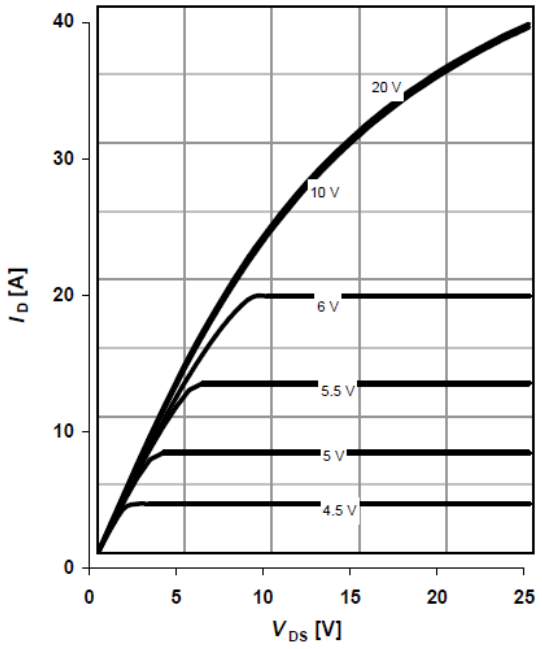
Max. Transient thermal impedance

$Z_{(thJC)}$=f(tp);Parameter: D=t_p/T; TO-220FullPAK



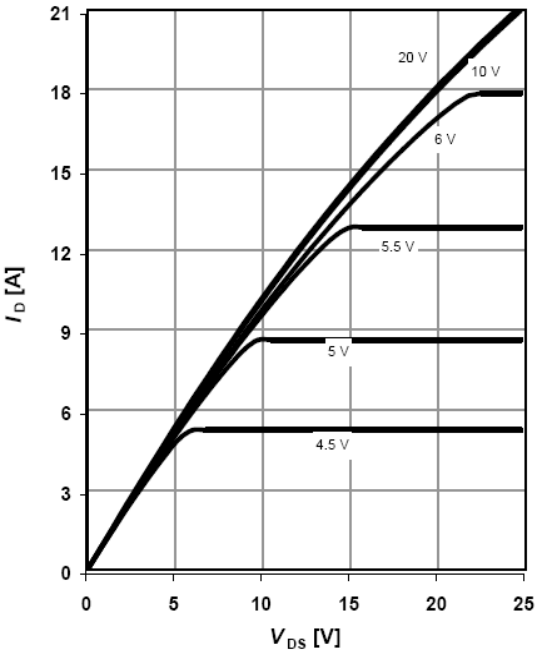
Typ. output characteristics

*I*D=f(*V*DS); *T*j=25 ℃; *t*p=10 μs; parameter: *V*GS



Typ. output characteristics

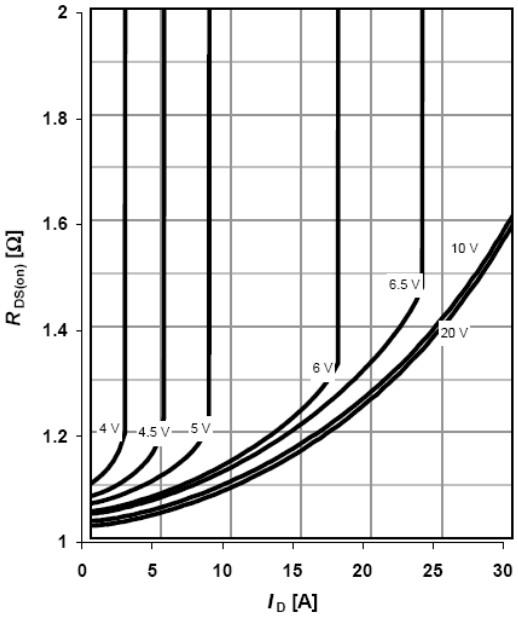
*I*D=f(*V*DS); *T*j=150 ℃; *t*p=10 μs; parameter: *V*GS



Typical Performance Characteristics

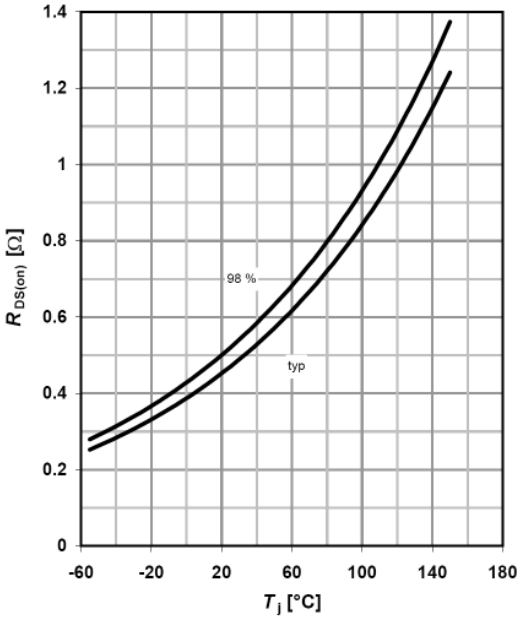
Typ. drain-source on-state resistance

*R*DS(on)=f(*I* D); *T* j=150 ℃; parameter: *V*GS



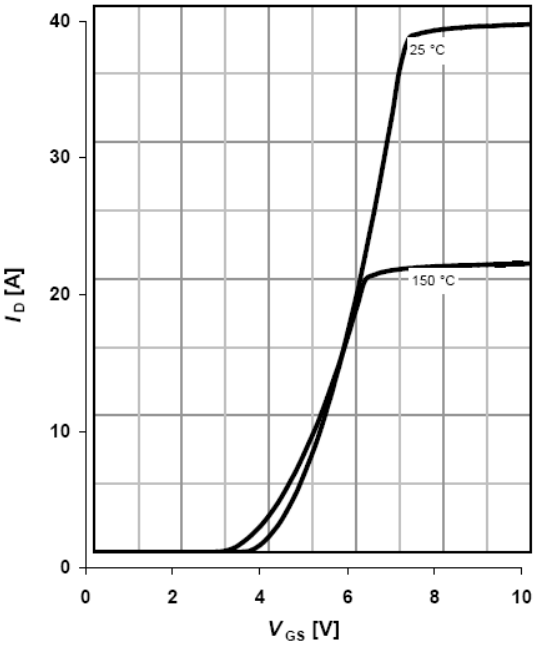
Drain-source on-state resistance

*R*DS(on)=f(*T* j); *ID*=5.5A; *V*GS=10V



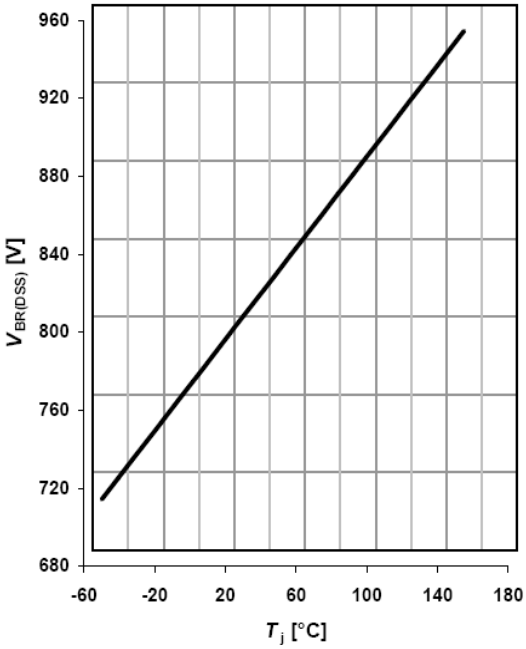
Typ. transfer characteristics

*I*D=f(*V*GS); |*V*DS|>2|*I*D|*R*DS(on)max; *t*p=10µs; parameter: Tj



Drain-source breakdown voltage

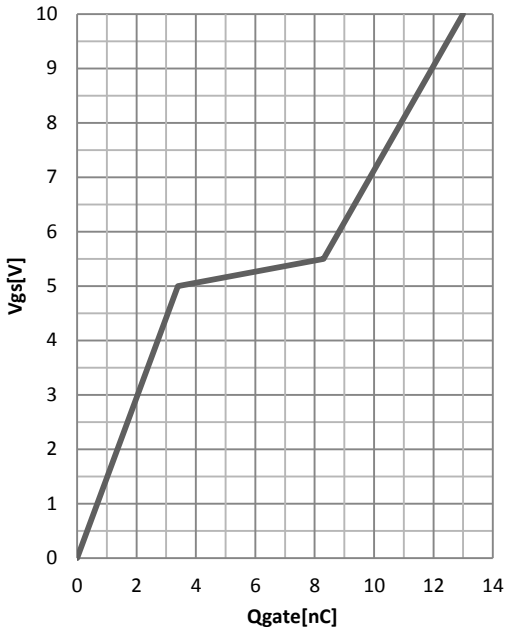
*V*BR(DSS)=f(*T* j); *I*D=0.25 mA



Typical Performance Characteristics

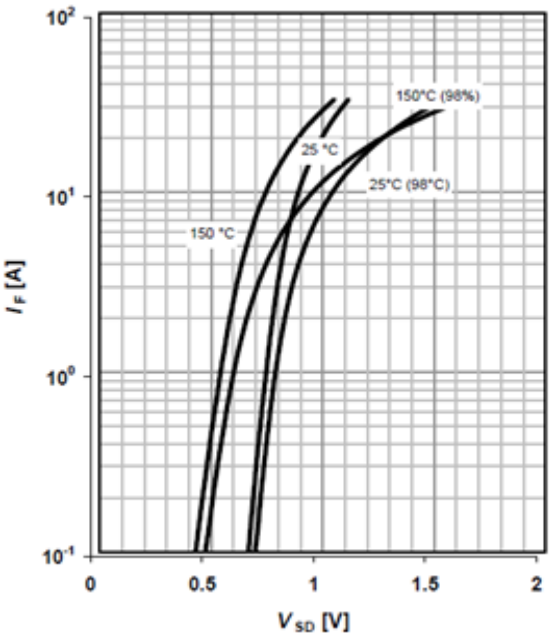
Typ. Gate charge

V_{GS}=f(Q_{gate}); I_D=5.5A pulsed



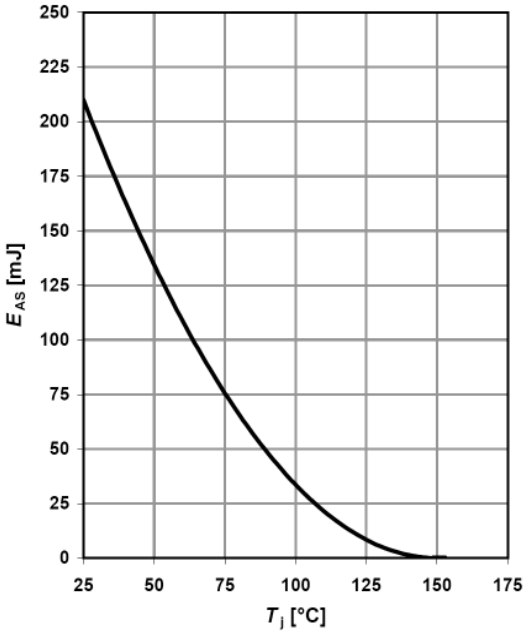
Forward characteristics of reverse diode

I_F=f(V_{DS}); parameter: T_j



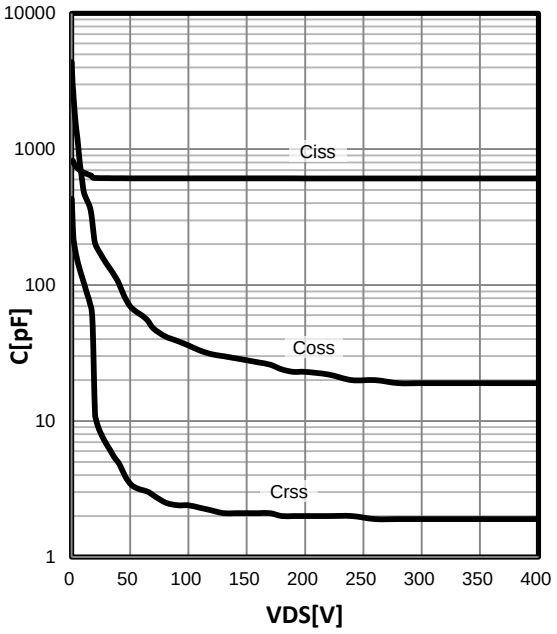
Avalanche energy

*E*AS=f(*T* j); *V*DD=50V



Typ. Capacitances

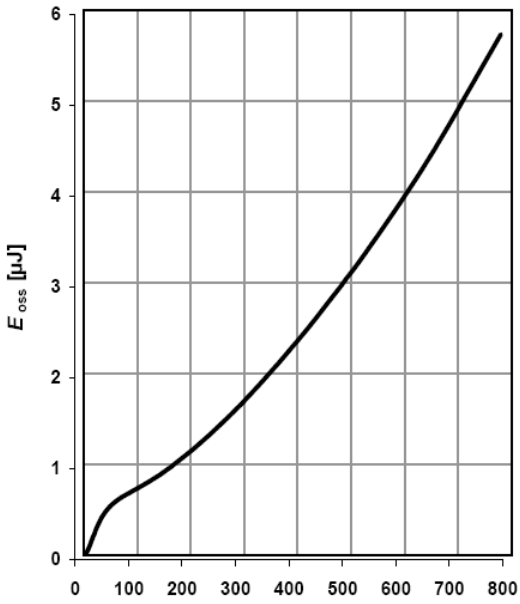
C=f(*V*DS); *V*GS=0 V; *f* =1 MHz



Typical Performance Characteristics

Typ. Coss stored energy

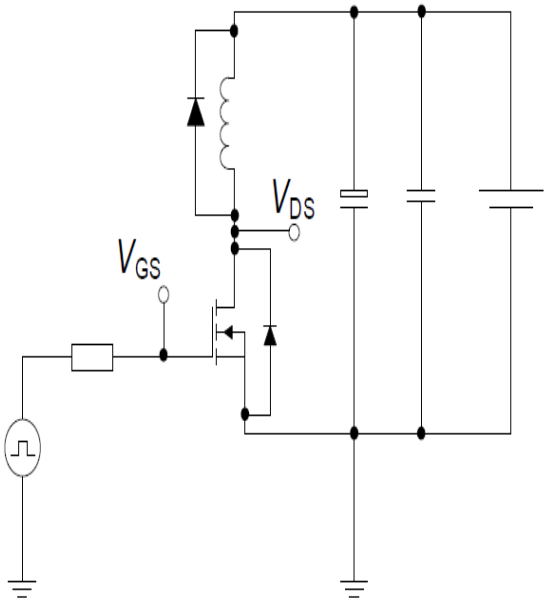
*E*oss= f*(V*DS*)*



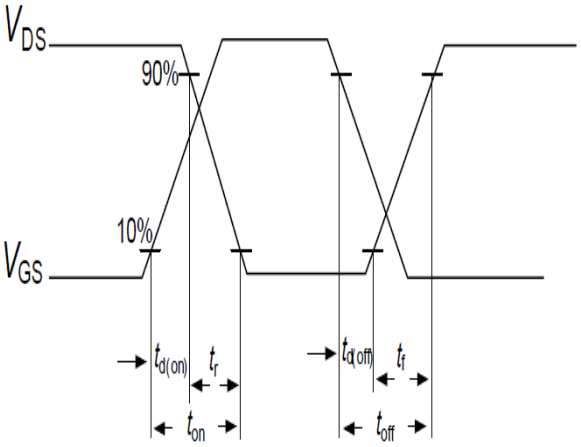
Test circuits

Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

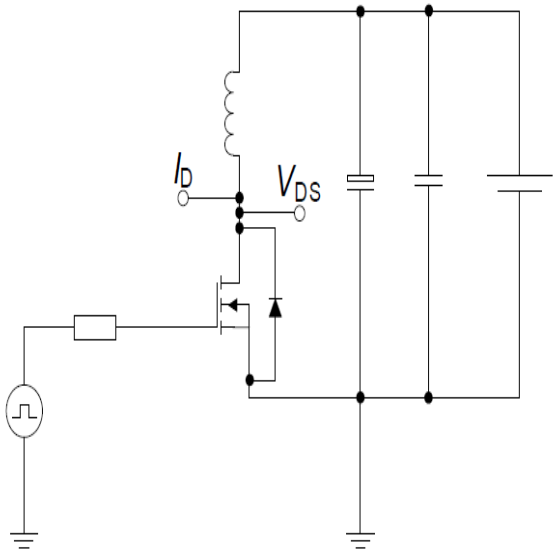


Switching time waveform

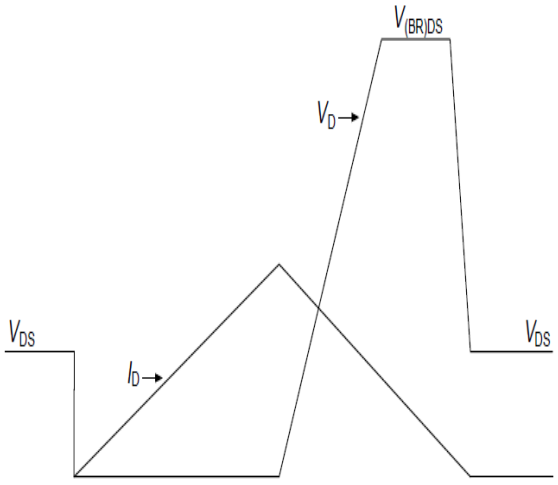


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit



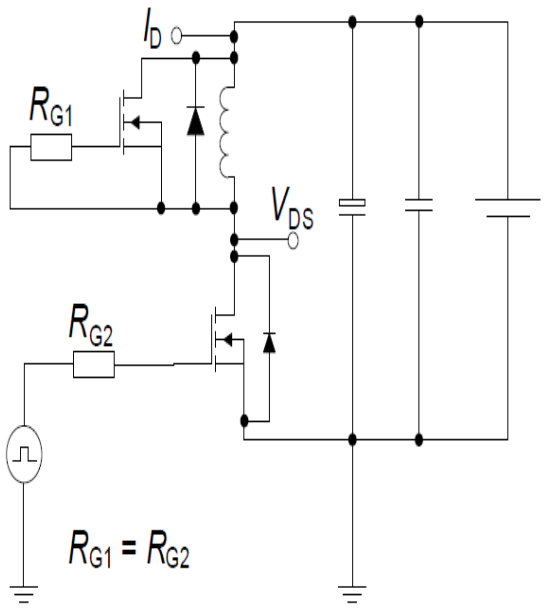
Unclamped inductive waveform



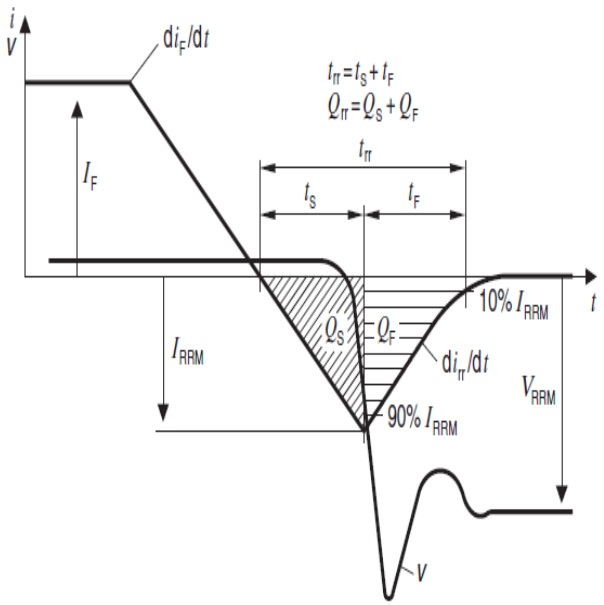
Test circuits

Test circuit and waveform for diode characteristics

Test circuit for diode characteristics

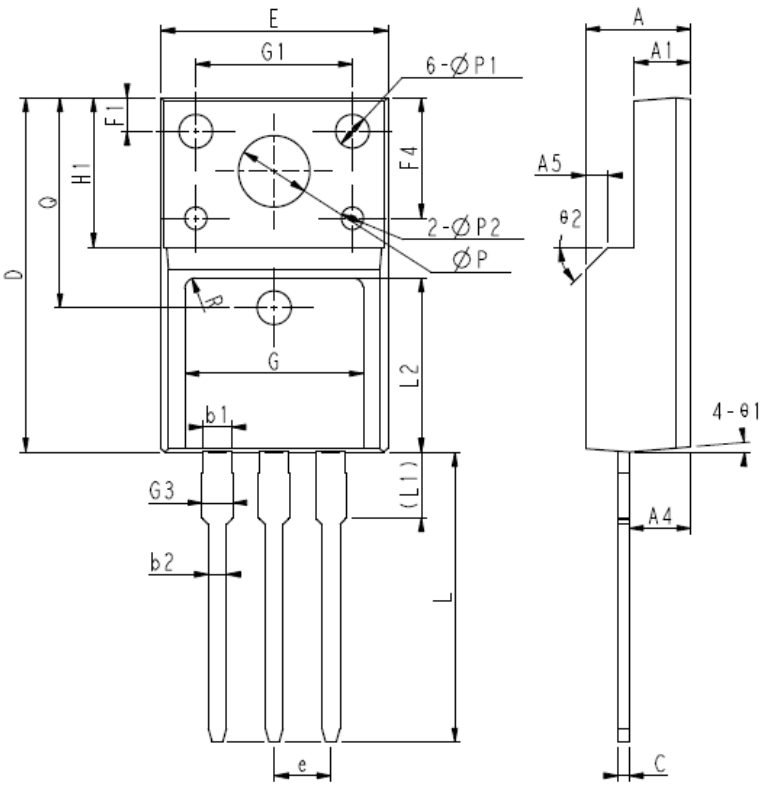


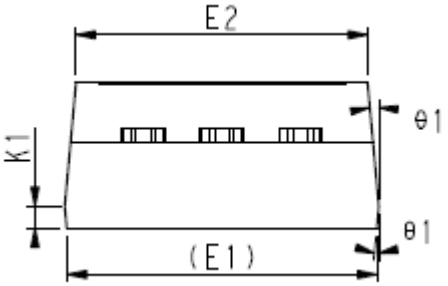
Diode recovery waveform



Package Outline

TO-220 Full PAK



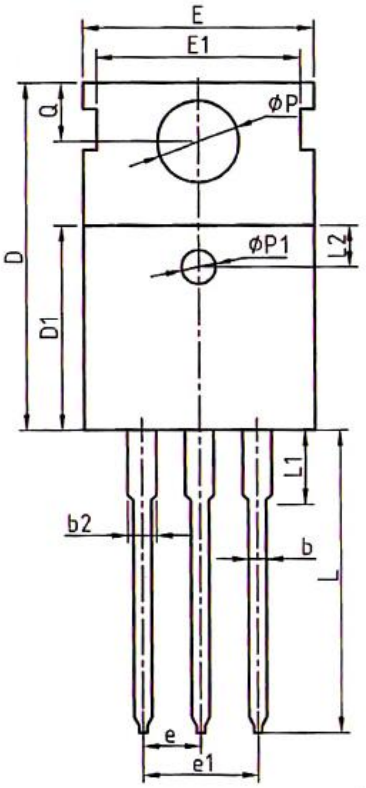


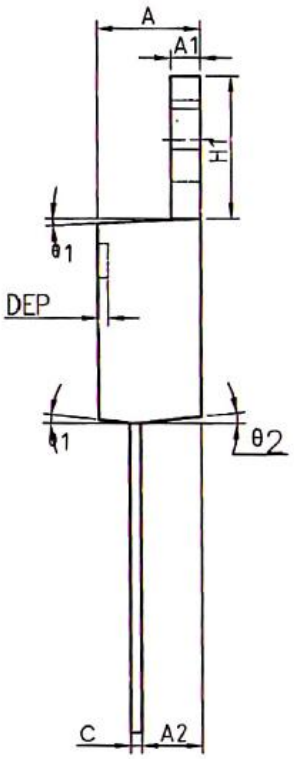
COMMON DIMENSIONS

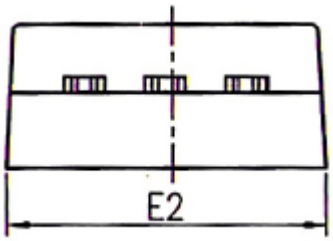
SYMBOL	MM		
	MIN	NOM	MAX
E	10.00	10.16	10.32
E1	9.94	10.04	10.14
E2	9.36	9.46	9.56
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A4	2.66	2.76	2.86
A5		1.00REF	
c	0.45	0.50	0.60
D	15.67	15.87	16.07
Q		9.40REF	
H1		6.70REF	
e		2.54BSC	
ΦP		3.18REF	
L	12.78	12.98	13.18
L1	2.83	2.93	3.03
L2	7.70	7.80	7.90
ΦP1	1.40	1.50	1.60
ΦP2	0.95	1.00	1.05
ΦP3		3.45REF	
θ1	3°	5°	7°
θ2	-	45°	-
F1	1.00	1.50	2.00
F2	13.80	13.90	14.00
F3	3.20	3.30	3.40
F4	5.30	5.40	5.50
G	7.80	8.00	8.20
G1	6.90	7.00	7.10
G3	1.25	1.35	1.45
b1	1.23	1.28	1.38
b2	0.75	0.80	0.90
K1	0.65	0.70	0.75
R		0.50REF	

Package Outline

TO-220





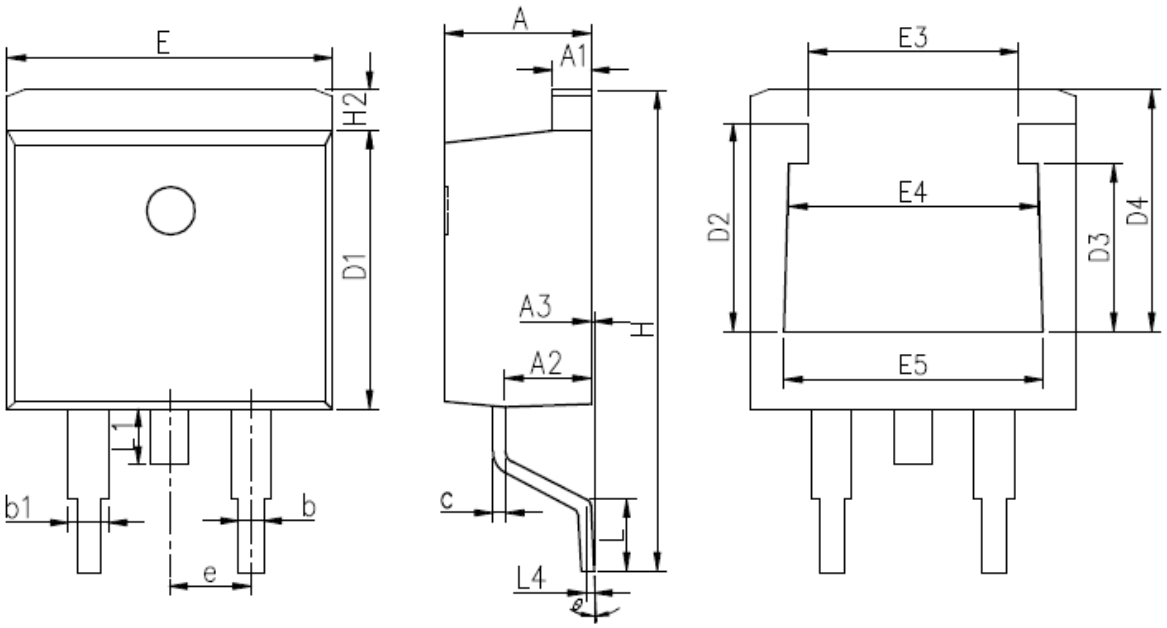


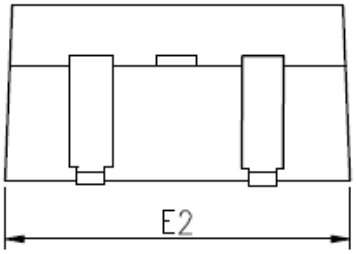
COMMON DIMENIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	4.40	4.57	4.70
A1	1.27	1.30	1.37
A2	2.35	2.40	2.50
b	0.77	0.80	0.90
b2	1.17	1.27	1.36
c	0.48	0.50	0.56
D	15.40	15.60	15.80
D1	9.00	9.10	9.20
DEP	0.05	0.10	0.20
E	9.80	10.00	10.20
E1	–	8.70	–
E2	9.80	10.00	10.20
ΦP1	1.40	1.50	1.60
e	2.54BSC		
e1	5.08BSC		
H1	6.40	6.50	6.60
L	12.75	13.50	13.65
L1	–	3.10	3.30
L2		2.50REF	
ΦP	3.50	3.60	3.63
Q	2.73	2.80	2.87
θ1	5°	7°	9°
θ2	1°	3°	5°
θ3	1°	3°	5°

Package Outline

TO-263



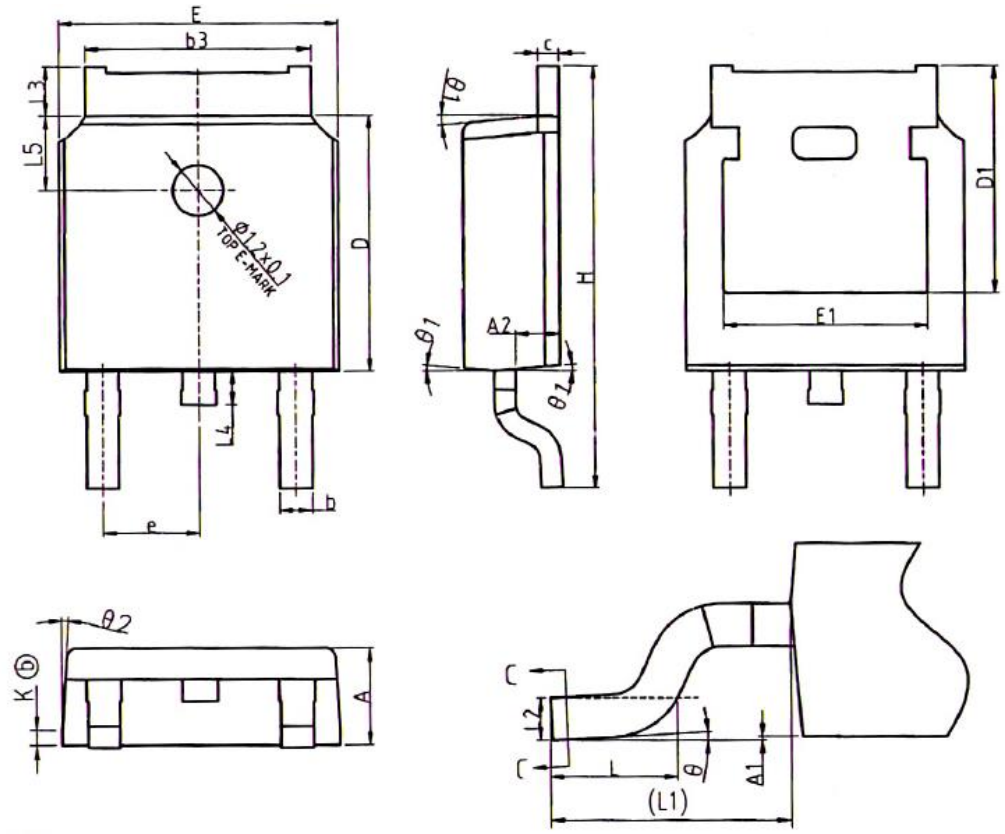


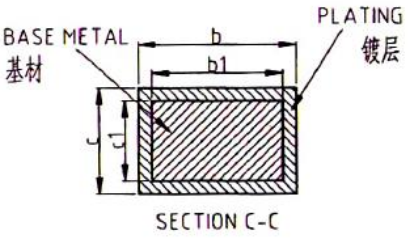
COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	4.27	4.57	4.87
A1	1.22	1.27	1.42
A2	2.39	2.69	2.99
A3	0.00	0.13	0.20
b	0.70	0.81	1.01
b1	1.17	1.27	1.50
c	0.30	0.38	0.53
D1	8.40	8.70	9.00
D2	5.33	6.33	6.63
D3	4.54	5.54	5.84
D4	6.60	7.60	8.00
E	9.88	10.16	10.50
E2	9.80	10.10	10.40
E3	4.94	5.94	6.24
E4	6.67	7.67	7.97
E5	7.06	8.06	8.36
e		2.54 BSC	
H	14.70	15.10	15.50
H2	1.00	1.27	1.50
L	2.00	2.30	2.60
L1	1.35	1.55	1.75
L4		0.25 BSC	
θ	0°	5°	9°

Package Outline

TO-252





COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	2.20	2.30	2.38
A1	0.00	-	0.10
A2	0.97	1.07	1.17
b	0.72	0.78	0.85
b1	0.71	0.76	0.81
b3	5.23	5.33	5.46
c	0.47	0.53	0.58
c1	0.46	0.51	0.56
D	6.00	6.10	6.20
D1		5.30REF	
E	6.50	6.60	6.70
E1	4.70	4.83	4.92
e		2.286BSC	
H	9.90	10.10	10.30
L	1.40	1.50	1.70
L1		2.90REF	
L2		0.51BSC	
L3	0.90	-	1.25
L4	0.60	0.80	1.00
L5	1.70	1.80	1.90
θ	0°	-	8°
θ1	5°	7°	9°
θ2	5°	7°	9°
K		0.40REF	

DISCLAIMER

SUPER SEMICONDUCTOR reserves the right to make changes WITHOUT further notice to any products herein to improve reliability, function, or design.

For documents and material available from this datasheet, SUPER SEMICONDUCTOR does not warrant or assume any legal liability or responsibility for the accuracy, completeness of any product or technology disclosed hereunder.

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, SUPER SEMICONDUCTOR hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

The products shown herein are not designed for use as critical components in medical, life-saving, or life-sustaining applications, whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness. Customers using or selling SUPER SEMICONDUCTOR products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify SUPER SEMICONDUCTOR for any damages arising or resulting from such use or sale.

INFORMATION

For further information on technology, delivery terms and conditions and prices, please contact SUPER SEMICONDUCTOR office or website (**www.supersemi.com.cn**).

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET ***category:***

Click to view products by Super Semiconductor ***manufacturer:***

Other Similar products are found below :

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3